

**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**

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Application Number	10/590,204
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First Named Inventor	Simon BATES
Art Unit	1797
Examiner Name	Bryan T. Kilpatrick
Attorney Docket Number	09013.0010-00000

U.S. PATENTS AND PUBLISHED U.S. PATENT APPLICATIONS

Examiner Initials	Cite No. ¹	Document Number	Issue or Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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Examiner Initials	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	Translation ⁶
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NONPATENT LITERATURE DOCUMENTS

Examiner Initials	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	Translation ⁶
	1	Office Action from U.S. Application 11/525,930 dated April 28, 2009.	
	2	Office Action from U.S. Application 11/525,930 dated January 20, 2010.	
	3	Schmidt, M. U., "The role of qualitative and quantitative analyses," Workshop: "Pharmaceutical Applications of X-Ray Power Diffraction," URL: http://www.anorg.chemie.uni-frankfurt.de/AK_Schmidt/epd1c.pdf , pgs. 1-24 (2006).	
	4	Petkov, V., et al., "High-resolution atomic distribution functions of disordered materials by high-energy X-ray diffraction," Journal of Non-Crystalline Solids, 293-295:726-730 (2001).	
Examiner Signature		Date Considered	

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.